

P-CHANNEL ENHANCEMENT MODE MOSFET

Product Summary

V _{(BR)DSS}	R _{DS(on) max}	I _D Τ _A = 25°C
-20V	42.5mΩ @ V _{GS} = - 4.5 V	-4.0A
-20V	$71m\Omega @ V_{GS} = -1.8V$	-2.0A

Description

This new generation MOSFET has been designed to minimize the onstate resistance ($R_{DS(on)}$) and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

Applications

- DC-DC Converters
- Power management functions

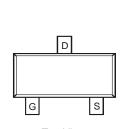
Features

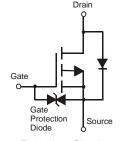
- Low On-Resistance
- Low Input Capacitance
- Fast Switching Speed
- Low Input/Output Leakage
- ESD Protected Up To 3kV
- Totally Lead-Free & Fully RoHS compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- Qualified to AEC-Q101 Standards for High Reliability

Mechanical Data

- Case: SOT23
- Case Material: Molded Plastic, "Green" Molding Compound.
- UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals: Finish Matte Tin annealed over Copper leadframe.
- Solderable per MIL-STD-202, Method 208 @3
- Terminals Connections: See Diagram Below
- Weight: 0.008 grams (approximate)







Top View Internal Schematic

Equivalent Circuit

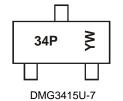
Ordering Information (Note 4)

Part Number	Qualification	Case	Packaging
DMG3415U-7	Commercial	SOT23	3,000/Tape & Reel
DMG3415UQ-7	Automotive	SOT23	3,000/Tape & Reel
DMG3415U-13	Commercial	SOT23	10,000/Tape & Reel

Notes:

- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.
- 2. See http://www.diodes.com for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. For packaging details, go to our website at http://www.diodes.com.

Marking Information



34P = Product Type Marking Code YW = Date Code Marking Y = Year (ex: W = 2009)

W = Week (ex: A \sim Z = Weeks 1 \sim 26 a \sim y = Weeks 27 \sim 51

a ~ y = Weeks 27 ~ 51 z = Weeks 52 and 53)



Maximum Ratings (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Value	Units		
Drain-Source Voltage	V_{DSS}	-20	V		
Gate-Source Voltage	V_{GSS}	±8	V		
Continuous Drain Current (Note 5) V _{GS} = -4.5V	Steady State	$T_A = +25$ °C $T_A = +70$ °C	I _D	-4.0 -3.5	А
Pulsed Drain Current (10µs pulse, duty cycle = 1%)			I _{DM}	-30	Α

Thermal Characteristics (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Value	Units
Total Power Dissipation (Note 5)	P_{D}	0.9	W
Thermal Resistance, Junction to Ambient (Note 5)	$R_{ heta JA}$	139	°C/W
Thermal Resistance, Junction to case (Note 5)	$R_{ heta JC}$	32	°C/W
Operating and Storage Temperature Range	T _J , T _{STG}	-55 to +150	°C

Electrical Characteristics (@T_A = +25°C, unless otherwise specified.)

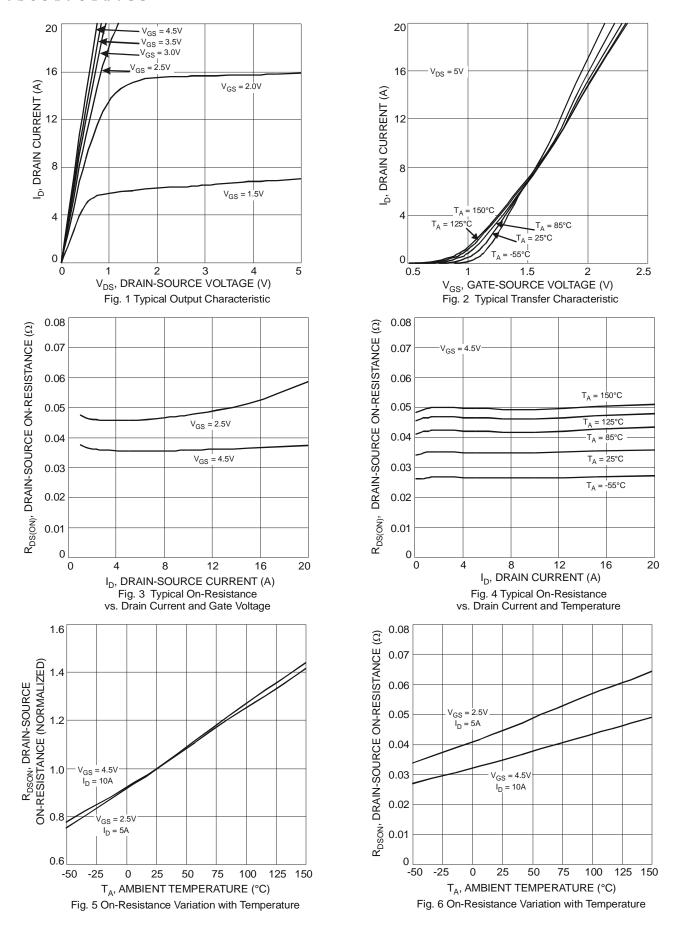
Characteristic	Symbol	Min	Tun	Max	Unit	Test Condition	
OFF CHARACTERISTICS (Note 6)	Syllibol	IVIIII	Тур	IVIAX	Offic	Test Condition	
Drain-Source Breakdown Voltage	BV _{DSS}	-20		l _	V	V _{GS} = 0V, I _D = -250μA	
Zero Gate Voltage Drain Current		_		-1	μA	$V_{DS} = -20V, V_{GS} = 0V$	
Gate-Source Leakage	I _{DSS}			±10	μA		
ON CHARACTERISTICS (Note 6)	I _{GSS}			±10	μΑ	$V_{GS} = \pm 8.0 V, V_{DS} = 0 V$	
` /	17	-0.3	0.55	-1.0	V	V V I 250	
Gate Threshold Voltage	V _{GS(th)}		-0.55		V	$V_{DS} = V_{GS}, I_{D} = -250\mu A$	
	1_		31	42.5		$V_{GS} = -4.5V, I_D = -4.0A$	
Static Drain-Source On-Resistance	R _{DS (ON)}		40	53	mΩ	$V_{GS} = -2.5V, I_D = -3.5A$	
		_	51	71		$V_{GS} = -1.8V, I_D = -2.0A$	
Forward Transfer Admittance	Y _{fs}		3	_	S	$V_{DS} = -5V, I_{D} = -4A$	
DYNAMIC CHARACTERISTICS							
Input Capacitance	Ciss	_	294	_	pF		
Output Capacitance	Coss		104	_	рF	$V_{DS} = -10V, V_{GS} = 0V$ - f = 1.0MHz	
Reverse Transfer Capacitance	C _{rss}		25	_	pF	T = 1.0WHZ	
Gate Resistnace	R_g		250		Ω	$V_{DS} = 0V$, $VGS = 0V$, $f = 1.0MHz$	
SWITCHING CHARACTERISTICS							
Total Gate Charge	Qg		9.1	_	nC	1/ 45)/)/ 40)/	
Gate-Source Charge	Q_{gs}	_	1.5	_	nC	$V_{GS} = -4.5V, V_{DS} = -10V$	
Gate-Drain Charge	Q_{gd}		1.7	_	nC	$I_D = -4A$	
Turn-On Delay Time	t _{D(on)}		71	_	ns		
Turn-On Rise Time	t _r	_	117	_	ns	$V_{DS} = -10V, V_{GS} = -4.5V,$	
Turn-Off Delay Time	t _{D(off)}	_	795	_	ns	$R_D = 2.5\Omega$, $R_G = 3.0\Omega$, $I_D = -1A$	
Turn-Off Fall Time	t _f	_	393	_	ns		

Notes:

- 5. Device mounted on FR-4 substrate PC board, with minimum recommended pad layout.
- 6. Short duration pulse test used to minimize self-heating effect.

DMG3415U Document number: DS31735 Rev. 9 - 2







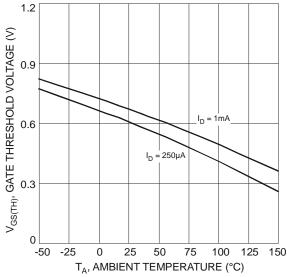


Fig. 7 Gate Threshold Variation vs. Ambient Temperature

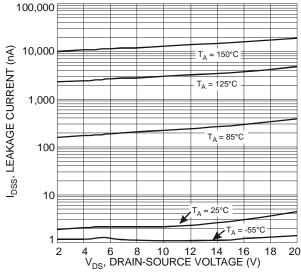
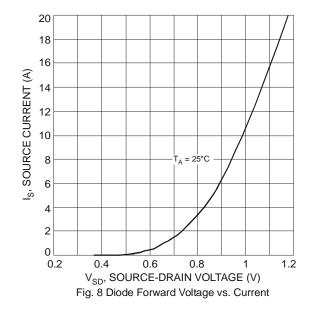


Fig. 9 Typical Leakage Current vs. Drain-Source Voltage



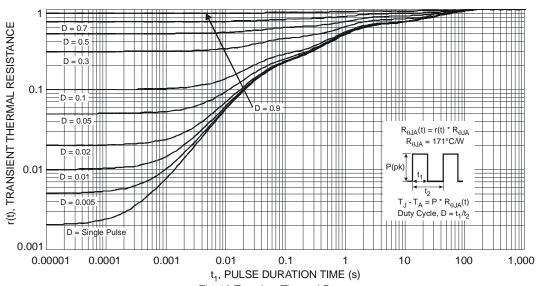
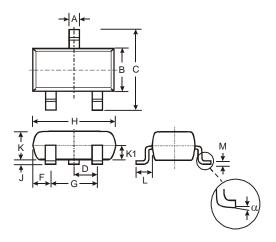


Fig. 10 Transient Thermal Response



Package Outline Dimensions

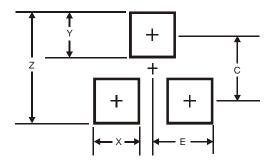
Please see AP02002 at http://www.diodes.com/datasheets/ap02002.pdf for latest version.



	SOT23						
Dim	Min	Max	Тур				
Α	0.37	0.51	0.40				
В	1.20	1.40	1.30				
С	2.30	2.50	2.40				
D	0.89	1.03	0.915				
F	0.45	0.60	0.535				
G	1.78	2.05	1.83				
Н	2.80	3.00	2.90				
J	0.013	0.10	0.05				
K	0.903	1.10	1.00				
K1	-	1	0.400				
L	0.45	0.61	0.55				
M	0.085	0.18	0.11				
α	0°	8°	-				
All	All Dimensions in mm						

Suggested Pad Layout

Please see AP02001 at http://www.diodes.com/datasheets/ap02001.pdf for the latest version.



Dimensions	Value (in mm)
Z	2.9
Х	8.0
Υ	0.9
C	2.0
F	1.35



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